

Notice of References Cited	Application/Control No. 10/709,325		Applicant(s)/Patent Under Reexamination DEVRIES ET AL.	
	Examiner Junghwa M. Im		Art Unit 2811	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,869,844	03-2005	Liu et al.	438/264
*	B	US-6,815,771	11-2004	Kimura, Yoshitaka	257/347
	C	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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